

Notice of References Cited	Application/Control No. 10/598,106		Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL.	
	Examiner LIN B. OLSEN		Art Unit 3661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,580,373	06-2003	Ohashi, Tamaki	340/901
*	B	US-6,675,006	01-2004	Diaz et al.	455/404.1
*	C	US-2002/0128769	09-2002	Der Ghazarian et al.	701/207
*	D	US-2003/0080877	05-2003	Takagi et al.	340/932.2
*	E	US-2003/0085999	05-2003	Okamoto et al.	348/148
*	F	US-2003/0095182	05-2003	Imoto, Masayoshi	348/148
*	G	US-2003/0222983	12-2003	Nobori et al.	348/148
*	H	US-2004/0196368	10-2004	Asai, Goro	348/148
*	I	US-2005/0174429	08-2005	Yanai, Tatsumi	348/148
*	J	US-2002/0080017	06-2002	Kumata et al.	340/436
*	K	US-2008/0150709	06-2008	Yamamoto et al.	340/441
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2005021330 A1	03-2005	World Intellect	KWON, OH SEOK	
	O	JP 2005014812 A	01-2005	Japan	TORII, AKIRA	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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